## Notice of References Cited Application/Control No. 10/695,415 Examiner Tod T. Van Roy Applicant(s)/Patent Under Reexamination KAWANISHI ET AL. Page 1 of 1

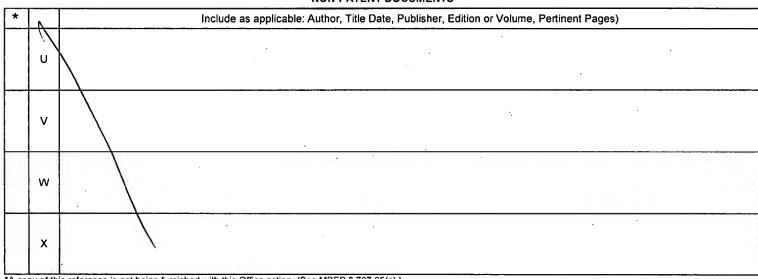
## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,912,237	06-2005	Ohkubo et al.	372/45.01
7	В	US-			
	F	US-			
	D	US-			
	Е	US-		*	
	F	USZ			
	G	US-	,		
	Н	US-			
	_	US-			
	J	US-	· .		
	К	US-		•	
	L	US-	1		
	M	US-		·	

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification ·
	N				·	
	0	.*				
	P			N.:		
	B					
	R					
	Ś					
	Т					

## **NON-PATENT DOCUMENTS**



\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.